

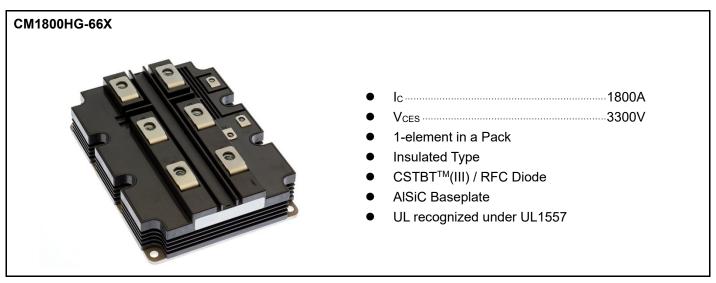
< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

# CM1800HG-66X

HIGH POWER SWITCHING USE

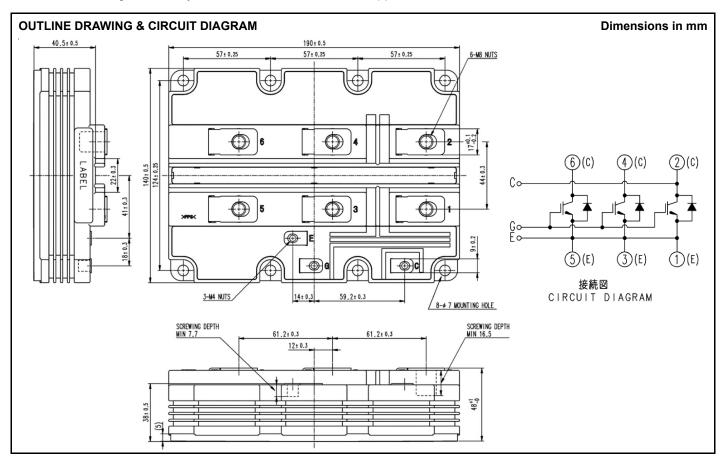
INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



#### **APPLICATION**

Traction drives, High Reliability Converters / Inverters, DC choppers



HIGH POWER SWITCHING USE

**INSULATED TYPE** 5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **MAXIMUM RATINGS**

Symbol	ltem	Conditions	Ratings	Unit
\/	Collector emitter veltage	V <sub>GE</sub> = 0V, T <sub>j</sub> = -40+150°C	3300	V
Vces	Collector-emitter voltage	$V_{GE} = 0V, T_j = -50^{\circ}C$	3200	V
V <sub>GES</sub>	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	± 20	V
Ic	Callagtar aumant	DC, T <sub>c</sub> = 105°C	1800	Α
I <sub>CRM</sub>	Collector current	Pulse (Note1)	3600	Α
lε	Consistent and and (Note2)	DC, T <sub>c</sub> = 95°C	1800	Α
I <sub>ERM</sub>	Emitter current (Note2)	Pulse (Note1)	3600	Α
P <sub>tot</sub>	Maximum power dissipation (Note3)	T <sub>c</sub> = 25°C, IGBT part	17800	W
Viso	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	10200	V
Ve	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q <sub>PD</sub> ≤ 10 pC	5100	V
Tj	Junction temperature		<b>−</b> 50 ~ <b>+</b> 150	°C
T <sub>jop</sub>	Operating junction temperature		-50 ~ +150	°C
T <sub>stg</sub>	Storage temperature		<b>−</b> 55 ~ <b>+</b> 150	°C
t <sub>psc</sub>	Short circuit pulse width	V <sub>CC</sub> = 2500V, V <sub>CE</sub> ≤ V <sub>CES</sub> , V <sub>GE</sub> =15V, T <sub>j</sub> =150°C	10	μS

#### **ELECTRICAL CHARACTERISTICS**

Cumbal	Item Conditions				Limits		Unit
Symbol	item	Conditions		Min.	Тур.	Max.	Unit
			T <sub>j</sub> = 25 °C	_	_	6.0	
Ices	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T <sub>j</sub> = 125 °C	_	6.0	_	mA
			T <sub>j</sub> = 150 °C	_	36.0	_	
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}, I_{C} = 180 \text{ mA}, T_{j} = 25 ^{\circ}$	C	6.5	7.0	7.5	V
I <sub>GES</sub>	Gate leakage current	$V_{GE} = V_{GES}$ , $V_{CE} = 0$ V, $T_j = 25$ °C		-0.5	_	0.5	μΑ
Cies	Input capacitance	, ,		_	208	_	
Coes	Output capacitance	V <sub>CE</sub> = 10 V, V <sub>GE</sub> = 0 V, f = 100 kHz T <sub>i</sub> = 25 °C			14.0	_	nF
Cres	Reverse transfer capacitance	1] - 23 C		_	1.9	_	
Q <sub>G</sub>	Total gate charge	V <sub>CC</sub> = 1800 V, I <sub>C</sub> = 1800 A, V <sub>GE</sub> = :	±15 V	_	13.5	_	μC
		L 4000 A (Noted)	T <sub>j</sub> = 25 °C	_	2.00	_	
$V_{CEsat}$	Collector-emitter saturation voltage	$I_C = 1800 \text{ A}^{\text{(Note4)}}$ $V_{GE} = 15 \text{ V}$	T <sub>j</sub> = 125 °C	_	2.50	_	V
		VGE - 13 V	T <sub>j</sub> = 150 °C	_	2.60	3.10	
t <sub>d(on)</sub>	Turn-on delay time		T <sub>j</sub> = 150 °C	_	_	0.90	μs
tr	Rise time	Vcc = 1800 V	T <sub>j</sub> = 150 °C	_	_	0.50	μs
	Turn-on switching energy per pulse (Note 5)	Ic = 1800 A	T <sub>j</sub> = 25 °C	_	2.75	_	
E <sub>on(10%)</sub>		V <sub>GE</sub> = ±15 V	T <sub>j</sub> = 125 °C	_	3.05	_	J
		$R_{G(on)} = 1.5 \Omega$	T <sub>j</sub> = 150 °C	_	3.20	_	
	Turn-on switching energy per pulse (Note 6)	Ls = 150 nH	T <sub>j</sub> = 25 °C	_	2.80	_	
Eon		Inductive load	T <sub>j</sub> = 125 °C	_	3.20	_	J
			T <sub>j</sub> = 150 °C	_	3.35	_	
			T <sub>j</sub> = 25 °C	_	2.90	_	
$t_{d(off)}$	Turn-off delay time		T <sub>j</sub> = 125 °C	_	3.20	_	μs
			T <sub>j</sub> = 150 °C	_	3.20	4.25	
	Fall time	V <sub>CC</sub> = 1800 V	T <sub>j</sub> = 25 °C	_	0.40	_	
tf		Ic = 1800 A	T <sub>j</sub> = 125 °C	_	0.45	_	μs
		V <sub>GE</sub> = ±15 V	T <sub>j</sub> = 150 °C	_	0.50	1.00	
E <sub>off(10%)</sub>	Turn-off switching energy per pulse (Note 5)	$R_{G(off)} = 12 \Omega$ Ls = 150 nH	T <sub>j</sub> = 25 °C	_	2.40	_	
			T <sub>j</sub> = 125 °C	_	3.15	_	J
	per pulse ( = //	Inductive load	T <sub>j</sub> = 150 °C		3.20	_	
			T <sub>j</sub> = 25 °C	_	2.55	_	
$E_{off}$	Turn-off switching energy per pulse (Note 6)		T <sub>j</sub> = 125 °C	_	3.20	_	J
	per pulse (Note 9)	$T_j = 150  ^{\circ}\text{C}$		_	3.45	_	

HIGH POWER SWITCHING USE

**INSULATED TYPE** 

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **ELECTRICAL CHARACTERISTICS**

Symbol	Item	Conditions		Limits			Unit
Symbol	item			Min.	Тур.	Max.	Ullit
		L = 4000 A (Note4)	T <sub>j</sub> = 25 °C	_	2.20	_	
VEC	Emitter-collector voltage (Note2)	I <sub>E</sub> = 1800 A (Note4)	T <sub>j</sub> = 125 °C	_	2.40	_	V
		$V_{GE} = 0 V$	T <sub>j</sub> = 150 °C	_	2.50	3.00	
			T <sub>j</sub> = 25 °C	_	1.20	_	
t <sub>rr</sub>	Reverse recovery time (Note2)		T <sub>j</sub> = 125 °C	_	1.35	_	μs
			T <sub>j</sub> = 150 °C	_	1.40	_	
			T <sub>j</sub> = 25 °C	_	_	_	
Irr	Reverse recovery current (Note2)		T <sub>j</sub> = 125 °C	_	2200	_	Α
		V <sub>CC</sub> = 1800 V I <sub>E</sub> = 1800 A	T <sub>j</sub> = 150 °C	_	2350	_	
	Reverse recovery charge (Note2, 7)		T <sub>j</sub> = 25 °C	_	1600	_	μC
Qrr(10%)			T <sub>j</sub> = 125 °C	_	2400	_	
		$V_{GE} = \pm 15 V$	T <sub>j</sub> = 150 °C	_	2500	_	
		$R_{G(on)} = 1.5 \Omega$	T <sub>j</sub> = 25 °C	_	1800	_	
Qrr	Reverse recovery charge (Note 2,6)	Ls = 150 nH	T <sub>j</sub> = 125 °C	_	2600	_	μC
		Inductive load	T <sub>j</sub> = 150 °C	_	2700	_	
	D		T <sub>j</sub> = 25 °C	_	1.85	_	
Erec(10%)	Reverse recovery energy per pulse (Note 2, 5)		T <sub>j</sub> = 125 °C	_	2.65	_	J
	per puise (Note 2, 3)		T <sub>j</sub> = 150 °C	_	3.00	_	
	Reverse recovery energy		T <sub>j</sub> = 25 °C	_	2.00	_	
Erec			T <sub>j</sub> = 125 °C	_	2.80	_	J
	per pulse (Note 2,6)		T <sub>j</sub> = 150 °C	_	3.15	_	

#### THERMAL CHARACTERISTICS

Cymphol	Item Conditions	Conditions	Limits			Linit
Symbol		Conditions	Min.	Тур.	Max.	Unit
R <sub>th(j-c)Q</sub>	Thermal resistance	Junction to Case, IGBT part	_	_	7.0	K/kW
R <sub>th(j-c)D</sub>	Thermal resistance	Junction to Case, FWDi part		_	11.0	K/kW
R <sub>th(c-s)</sub>	Contact thermal resistance	Case to heat sink $\lambda_{grease} = 1W/m \cdot k$ , $D_{(c-s)} = 80 \mu m$	_	5.0	_	K/kW

#### **MECHANICAL CHARACTERISTICS**

Cymbal	Item	Conditions	Limits			Unit
Symbol		Conditions		Тур.	Max.	Unit
Mt		Main terminals screw : M8	7.0	_	19.0	N·m
Ms	Mounting torque	Mounting screw : M6	3.0	_	6.0	N⋅m
Mt		Auxiliary terminals screw : M4	1.0	_	3.0	N·m
m	Mass		_	1.5	_	kg
CTI	Comparative tracking index		600	_	_	_
da	Clearance		26.0	_	_	mm
ds	Creepage distance		56.0	_	_	mm
L <sub>P CE</sub>	Parasitic stray inductance		_	13.5	_	nΗ
Rcc'+EE'	Internal lead resistance	T <sub>c</sub> = 25 °C	_	0.12	_	mΩ

Note 1. Pulse width and repetition rate should be such that junction temperature  $(T_j)$  does not exceed  $T_{jopmax}$  rating.

Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD<sub>i</sub>).

Note3. Junction temperature (T<sub>j</sub>) should not exceed T<sub>jmax</sub> rating (150°C).

Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

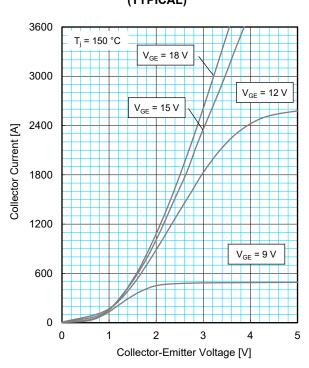
Note5. The integration range of switching energies is from  $10\%V_{CE}$  to  $10\%I_{C}(10\%I_{E})$ .

Note6. Definition of all items is according to IEC 60747, unless otherwise specified.

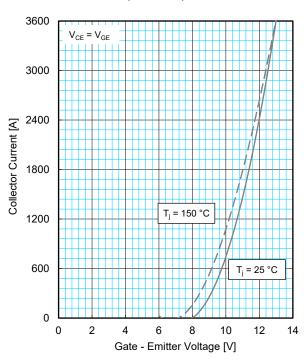
Note7. The integration range of reverse recovery charge is from  $I_{\text{E}}$  = 0A to 10%  $I_{\text{E}}.$ 

#### **PERFORMANCE CURVES**

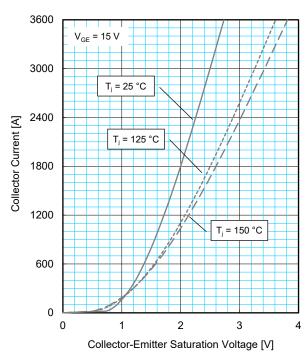




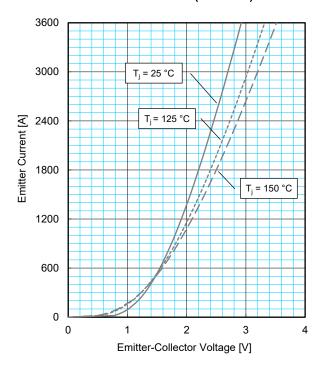
# TRANSFER CHARACTERISTICS (TYPICAL)



# COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



# FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

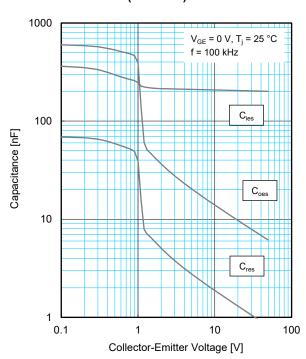


HIGH POWER SWITCHING USE

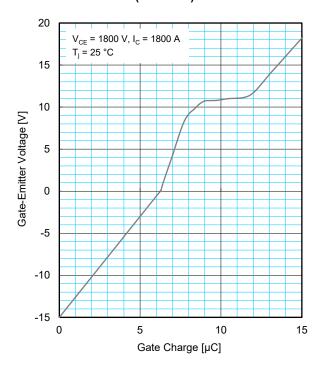
INSULATED TYPE 5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **PERFORMANCE CURVES**

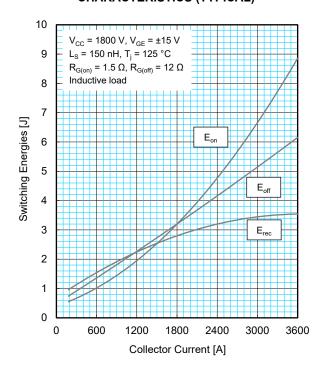
# CAPACITANCE CHARACTERISTICS (TYPICAL)



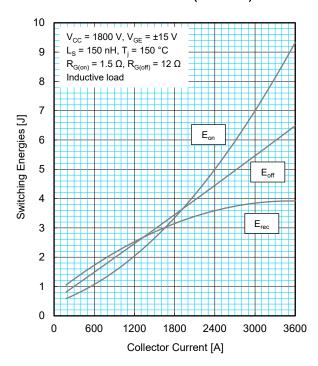
# GATE CHARGE CHARACTERISTICS (TYPICAL)



#### HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



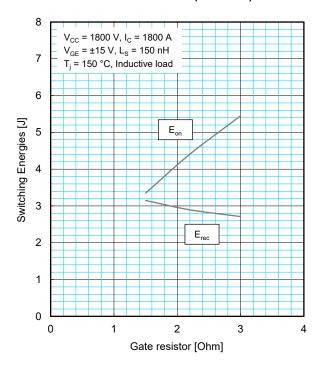
HIGH POWER SWITCHING USE

INSULATED TYPE

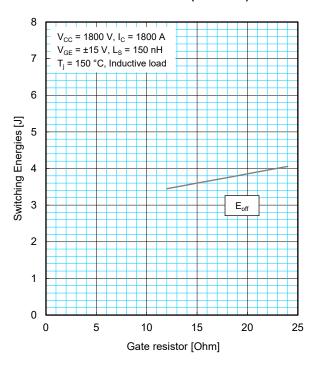
5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **PERFORMANCE CURVES**

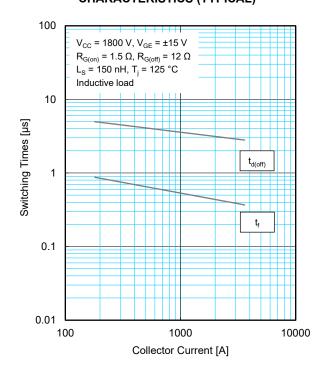
# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



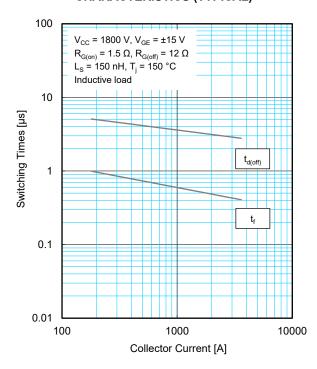
# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



## HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



# HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

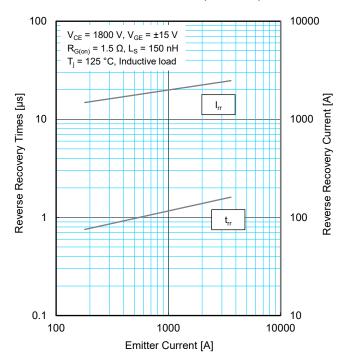


HIGH POWER SWITCHING USE

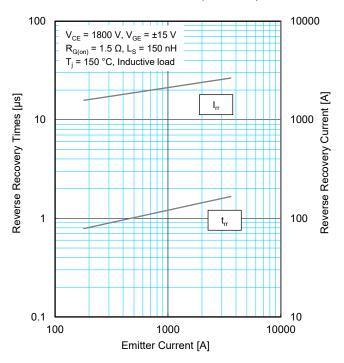
**INSULATED TYPE** 5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

#### **PERFORMANCE CURVES**

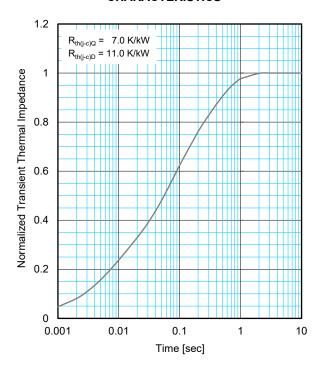
## FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



## FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



## TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - \exp\left(-\frac{t}{\tau_{i}}\right) \right\}$$

_		1	2	3	4
	$R_i / R_{th}$	0.0096	0.1893	0.4044	0.3967
	τ <sub>i</sub> [sec]	0.0001	0.0058	0.0602	0.3512

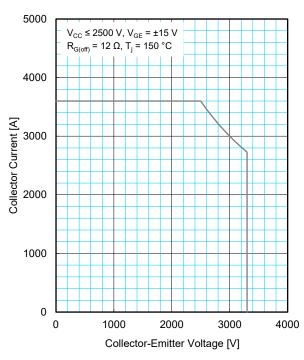
HIGH POWER SWITCHING USE

INSULATED TYPE

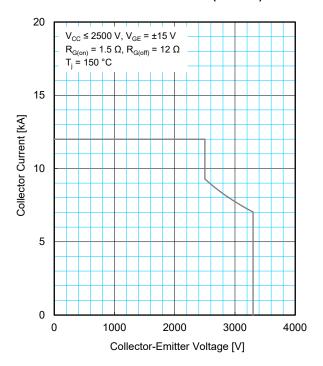
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#### **PERFORMANCE CURVES**

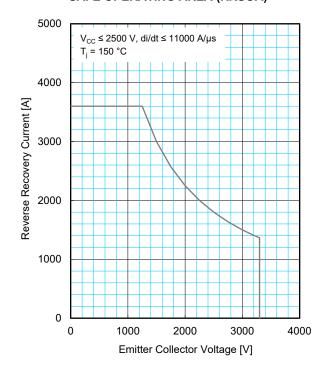
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



# SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



# FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



< High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

### CM1800HG-66X

HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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HIGH POWER SWITCHING USE INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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